



DAF-003-0491101 Seat No. _____

B. Sc. / M. Sc. (Sem. X) (CBCS) Examination

April - 2022

Applied Physics : Paper -13 (Core-10)

(Ion Beams in Materials Science)

(New Course)

Faculty Code : 003

Subject Code : 0491101

Time : $2\frac{1}{2}$ Hours]

[Total Marks : 70

- Instructions :** (1) All questions are compulsory.
(2) Number in the right side margin indicate marks.

1 Attempt any **SEVEN** short questions (**Two** marks each) **14**

- (1) What are the basic approaches in the synthesis of nanostructures ?
- (2) Write down any two limitations of the Rutherford backscattering spectrometry (RBS).
- (3) Define straggling with its types.
- (4) List the name of line defect and define Burger's Vector.
- (5) Define kinematic factor for RBS.
- (6) What is channelling ?
- (7) What is the sputter yield ? Write any two applications of sputtering ?
- (8) Write down any two applications of Secondary Ion Mass Spectrometer (SIMS).
- (9) Explain radiation enhanced diffusion process in solids.
- (10) What is the disadvantage if one wishes to do ERD measurements on "RBS set-up" i.e., by using beam of α -particles ?

2 Write the answer of any two questions : 14

- (1) Give a brief overview of overview of what energetic ions can do while interacting with the material.
- (2) Write a short note on the radiation enhanced diffusion process. State the difference between Schottky defect and Frenkel defects ?
- (3) What is ion implantation ? What are the applications of ion implantation in material science ?
- (4) What do you mean by kinematic factor in case of ERDA? In an elastic scattering recoil detection experiment, an incident, particle of mass M_1 , having energy E_0 is colliding with the target atom at rest having mass M_2 . After the collision, particle of mass M_1 has energy E_1 and it is scattered at an angle θ . The target particle is scattered at angle ϕ with energy E_2 , then derive the expression of kinematic factor ? Give a list of assumptions taken to derive this expression?

3 Write a the answer of any two questions. 14

- (1) Draw a schematic diagram to explain channeling in the single crystal ? How channeling can be used for identification of substitutional and interstitial types of impurities in the doped semiconductor ? Describe working principle of the $\Delta E - E$ telescope detector for analysis of carbon thin film having impurity of the Li and O ?
- (2) Find the energy of the particles as well as the thickness of Au layer if the RBS spectrum contains 5,000 counts of α -particles backscattered from this Au layer ? Given : Incident angle $\alpha = 0^\circ$, scattering angle $\theta = 170^\circ$, $E = 2 \text{ MeV}$, $\Delta\Omega = 10^{-3}$ steradian,
 $Q = 10 \mu\text{C}$, $d\sigma/d\Omega = 8.0634$ barn steradian⁻¹ for $E = 2,000$ ke V and density of Au as 19.31 g cm^{-3}
- (3) State the working principle of the NRA. Why NRA is use to measure the low Z-elements ? Write down the parameters which determine the (a) energy and (b) yield of the emitted particle in case of NRA ?
- (4) Explain the working principle of RBS ?

- 4 Write the answer of any two questions. 14
- (1) Write a short note on the in-situ technique used in the investigation of the irradiation induced phase transformations.
 - (2) What are advantages and drawbacks of ion implantation for incorporation impurity in a semiconductor ?
 - (3) Explain the role of swift heavy ions (SHI) in Nano structuring.
 - (4) Explain the depinning of Fermi level along ion tracks.
- 5 Write the answer of any two questions. 14
- (1) Define sputtering process. Write a short note on nuclear and electronic sputtering.
 - (2) What is the importance of ion implantation in the creation of controlled defects ? Explain point defects, line defects, and columnar defects produced by energetic ion irradiation.
 - (3) What is the difference between crystalline and amorphous solids ? Explain the ion beam induced epitaxial crystallization process.
 - (4) What is ion beam mixing ? Discuss importance of the ion beam mixing for the synthesis of alloys.
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